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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/710,197	JIANG, SAM SHIAW-SHIANG	
Examiner	Art Unit	
Simon A. Goetze	2617	

SEARCHED					
Class	Subclass	Date	Examiner		
370	329	9/17/2007	SAG		
370	412	9/17/2007	SAG		
370 .	417	9/17/2007	SAG		
370	230	9/17/2007	SAG		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST image and keyword search (USPAT; US-PGPUB; USOCR; EPO; JPO; DERWENT; IBM_TDB).	9/17/2007	SAG		
Consulted with Rafael Perez-Gutierrez (Class 455) and Greg Sefcheck (Class 370).	9/17/2007	SAG		
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